# SLOVENSKI STANDARD

**SIST EN 61746:2005** 

november 2005

## Kalibriranje optične časovne domene reflektometrov (OTDR) (IEC 61746:2005)

Calibration of optical time-domain reflectometers (OTDR) (IEC 61746:2005)

# iTeh STANDARD PREVIEW (standards.iteh.ai)

<u>SIST EN 61746:2005</u> https://standards.iteh.ai/catalog/standards/sist/49b366c2-b9be-467c-82ace7962d5aa8b6/sist-en-61746-2005

ICS 17.180.30; 33.180.99

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## **EUROPEAN STANDARD**

## EN 61746

# NORME EUROPÉENNE

## **EUROPÄISCHE NORM**

March 2005

ICS 33.180.01

Supersedes EN 61746:2001

English version

# Calibration of optical time-domain reflectometers (OTDR) (IEC 61746:2004)

Etalonnage des réflectomètres optiques dans le domaine de temps (OTDR) (CEI 61746:2004)

Kalibirerung optischer Rückstreumessgeräte (OTDR) (IEC 61746:2004)

### iTeh STANDARD PREVIEW

This European Standard was approved by CENELEC on 2005-02-01. CENELEC members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this European Standard the status of a national standard without any alteration.

Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the Central Secretariat or to any CENELEO member 9be-467c-82ac-

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This European Standard exists in three official versions (English, French, German). A version in any other language made by translation under the responsibility of a CENELEC member into its own language and notified to the Central Secretariat has the same status as the official versions.

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# **CENELEC**

European Committee for Electrotechnical Standardization Comité Européen de Normalisation Electrotechnique Europäisches Komitee für Elektrotechnische Normung

Central Secretariat: rue de Stassart 35, B - 1050 Brussels

### **Foreword**

The text of document 86/230/FDIS, future edition 2 of IEC 61746, prepared by IEC TC 86, Fibre optics, was submitted to the IEC-CENELEC parallel vote and was approved by CENELEC as EN 61746 on 2005-02-01.

This European Standard supersedes EN 61746:2001.

Specific changes to EN 61746:2001 include the development of Clause 9, "Reflectance calibration", and the introduction of Annexes E, F and G.

The following dates were fixed:

 latest date by which the EN has to be implemented at national level by publication of an identical national standard or by endorsement

(dop) 2005-11-01

 latest date by which the national standards conflicting with the EN have to be withdrawn

(dow) 2008-02-01

Annex ZA has been added by CENELEC.

## iTeh STANDARD PREVIEW

# (standardent hoticei)

The text of the International Standard IEC 61746:2005 was approved by CENELEC as a European Standard without any modification. iteh ai/catalog/standards/sist/49b366c2-b9be-467c-82ac-e7962d5aa8b6/sist-en-61746-2005

In the official version, for Bibliography, the following notes have to be added for the standards indicated:

IEC 60825-1 NOTE Harmonized as EN 60825-1:1994 (not modified).

IEC 60825-2 NOTE Harmonized as EN 60825-2:2004 (not modified).

IEC 61300-3-6 NOTE Harmonized as EN 61300-3-6:2003 (not modified).

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### **Annex ZA** (normative)

### Normative references to international publications with their corresponding European publications

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE Where an international publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	EN/HD	<u>Year</u>
IEC 60793-1	Series	Optical fibres Part 1: Measurement methods and test procedures	EN 60793-1	Series
IEC 60793-1-40 (mod)	_ 1)	Optical fibres Part 1-40: Measurement methods and test procedures – Attenuation	EN 60793-1-40	2003 2)
IEC 60794-1-2	- <sup>1)</sup>	Optical fibre cables Part 1-2: Generic specification - Basic   F   optical cable test procedures (standards iteh ai)	EN 60794-1-2	2003 2)
IEC 61300-3-2	_ 1) https://sta	Fibre optic interconnecting devices and passive components - Basic tests and measurement procedures Part 3-2. Examinations and measurements - Polarization dependence of attenuation in a single-mode fibre optic device	EN 61300-3-2 'c-82ac-	1999 <sup>2)</sup>
ITU-T Recommendation G.650.1	2004	Definitions and test methods for linear, deterministic attributes of single-mode fibre and cable	-	-
ITU-T Recommendation G.650.2	2002	Definitions and test methods for statistical and non-linear attributes of single-mode fibre and cable	-	-

<sup>1)</sup> Undated reference.

<sup>&</sup>lt;sup>2)</sup> Valid edition at date of issue.

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# NORME INTERNATIONALE INTERNATIONAL STANDARD

CEI IEC 61746

Deuxième édition Second edition 2005-01

# Etalonnage des réflectomètres optiques dans le domaine de temps (OTDR)

# Calibration of optical time-domain iTreflectometers (QTDR)REVIEW (standards.iteh.ai)

<u>SIST EN 61746:2005</u> https://standards.iteh.ai/catalog/standards/sist/49b366c2-b9be-467c-82ace7962d5aa8b6/sist-en-61746-2005

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International Electrotechnical Commission, 3, rue de Varembé, PO Box 131, CH-1211 Geneva 20, Switzerland Telephone: +41 22 919 02 11 Telefax: +41 22 919 03 00 E-mail: inmail@iec.ch Web: www.iec.ch



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### INTERNATIONAL ELECTROTECHNICAL COMMISSION

# CALIBRATION OF OPTICAL TIME-DOMAIN REFLECTOMETERS (OTDR)

### FOREWORD

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International Standard IEC 61746 has been prepared by IEC technical committee 86: Fibre optics.

This second edition cancels and replaces the first edition published in 2001. It constitutes a technical revision. Specific technical changes include the development of Clause 9, "Reflectance calibration," and the introduction of Annexes E, F and G.

The text of this standard is based on the following documents:

FDIS	Report on voting
86/230/FDIS	86/232/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

The committee has decided that the contents of this publication will remain unchanged until the maintenance result date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- · reconfirmed;
- withdrawn;
- · replaced by a revised edition, or
- amended.

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# CALIBRATION OF OPTICAL TIME-DOMAIN REFLECTOMETERS (OTDR)

### 1 Scope

This International Standard provides procedures for calibrating single-mode optical time domain reflectometers (OTDR). It only covers OTDR measurement errors and uncertainties.

This standard does not cover correction of the OTDR response.

In order for an OTDR to qualify as a candidate for complete calibration using this standard, it must be equipped with the following minimum feature set:

- a) a programmable index of refraction, or equivalent parameter;
- b) the ability to present a display of a trace representation, with a logarithmic power scale and a linear distance scale;
- two markers/cursors, which display the loss and distance between any two points on a trace display;
- d) the ability to measure absolute distance (location) from the OTDR's zero-distance reference;
- e) the ability to measure the displayed power level relative to a reference level (for example, the clipping level).
- f) the ability to evaluate the reflectance of a reflective event.

### SIST EN 61746:2005

### 2 Normative references iteh.ai/catalog/standards/sist/49b366c2-b9be-467c-82ace7962d5aa8b6/sist-en-61746-2005

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60793-1 (all parts), Optical fibres - Part 1: Measurement methods and test procedures

IEC 60793-1-40, Optical fibres – Part 1-40: Measurement methods and test procedures – Attenuation

IEC 60794-1-2, Optical fibre cables – Part 1-2: Generic specification – Basic optical cable test procedures

IEC 61300-3-2, Fibre optic interconnecting devices and passive components – Basic test and measurement procedures – Part 3-2: Examinations and measurements – Polarization dependence of attenuation in a single-mode fibre optic device

ITU-T Recommendation G.650.1:2004, Definitions and test methods for linear, deterministic attributes of single-mode fibre and cable

ITU-T Recommendation G.650.2:2002, Definitions and test methods for statistical and non-linear attributes of single-mode fibre and cable

### Terms, definitions and symbols

For the purposes of this document, the following definitions apply.

NOTE For more precise definitions, the references to IEC 60050-731 should be consulted.

#### 3.1

### attenuation

 $\boldsymbol{A}$ 

loss

optical power decrease in decibels (dB)

NOTE  $\,$  If  $P_{in}$  (watts) is the power entering one end of a segment of fibre and  $P_{out}$  (watts) is the power leaving the other end, then the attenuation of the segment is

$$A = 10\log_{10}\left(\frac{P_{\text{in}}}{P_{\text{out}}}\right) \text{ dB} \tag{1}$$

[IEV 731-01-48, modified]

### 3.2

### attenuation coefficient

attenuation of a fibre per unit length

[IEV 731-03-42, modified]

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### 3.3

### attenuation dead zone

for a reflective or attenuating event, the region after the event where the displayed trace deviates from the undisturbed backscatter trace by more than a given vertical distance  $\Delta F$ 

NOTE The attenuation dead zone will depend on the following event parameters: reflectance, loss, displayed power level and location. It may also depend on any fibre optic component in front of the event.

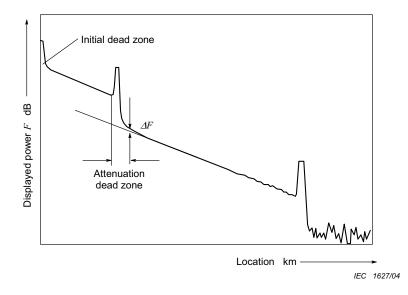


Figure 1 - Definition of attenuation dead zone

### 3.4

### backscatter parameter

at a given point along the fibre, the backscattered propagating power per unit incident energy

NOTE 1 K is given by the following formula:

$$K = S\alpha_{\rm s} \frac{v}{2} \quad {\rm s}^{-1} \tag{2}$$

where

is the scattering coefficient, e.g.; in m<sup>-1</sup>  $\alpha_{\rm S}$ 

is the backscatter capture fraction. It depends on other standard fibre parameters such as the mode field S diameter in single mode fibre;

is the group velocity, in metres per second;  $\nu$ 

= c / N where c is the speed of the light in vacuum, N the group index of the fibre.

NOTE 2 See also Annex G.

### 3.5

### backscatter coefficient

for a given pulse, the ratio of backscattered power at the input side of the fibre to the pulse input power

NOTE 1 It represents the backscatter parameter for a given pulse width. The backscatter coefficient is defined from the backscatter parameter using the following formula: C ( $\Delta T$ ) =  $K\Delta T$  (C ( $\Delta T$ ) = C (C (C) = C (C) =

$$C(\Delta T) = K\Delta T$$
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where  $\Delta T$  is the pulse width, e.g. in seconds

Usually the backscatter coefficient is expressed in dB for a given pulse width,  $\Delta T$ .

NOTE 2 The pulse width,  $\Delta T$  in the previous formula is used to normalise C ( $\Delta T$ ). Usual values for  $\Delta T$  are 1 ns and 1 µs. See also Annex G.

### 3.6

#### calibration

set of operations which establish, under specified conditions, the relationship between the values indicated by the measuring instrument and the corresponding known values of that quantity

NOTE See ISO Guide International vocabulary of basic and general terms in metrology.

### 3.7

### centre wavelength

### $\lambda_{centre}$

power-weighted mean wavelength of a light source in vacuum, in nanometres (nm)

NOTE For a continuous spectrum, the centre wavelength is defined as:

$$\lambda_{\text{centre}} = \frac{1}{P_{\text{total}}} \int p(\lambda) \lambda d\lambda \tag{5}$$

For a spectrum consisting in discrete lines, the centre wavelength is defined as:

$$\lambda_{\text{centre}} = \frac{\sum_{i} P_{i} \lambda_{i}}{\sum_{i} P_{i}}$$
 (6)